## Notice of References Cited Application/Control No. 10/823,988 Examiner John A. Tweel, Jr. Applicant(s)/Patent Under Reexamination MILLER ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,940,426	09-2005	Vaida, Theodore F.	340/963
*	В	US-7,131,136	10-2006	Monroe, David	340/945
*	C	US-7,161,501	01-2007	Lynch et al.	340/971
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

	HON-I ATENI BOOOMENTO							
*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
-	U							
	٧							
	w							
	x							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.